



Characterisation

Post-processing

Processing

Substrates

Glass Wafers	(80)
Silicon (CMOS Compatible)	(137)
Silicon (MEMS)	(130)
Silicon (Other)	(121)
III-V	(125)
Other Substrates	(122)

Equipment

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Substrates

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Other Substrates	(122)

Equipment

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- Processing

Substrates

- Glass Wafers Silicon (CMOS Compatible) (137) Silicon (MEMS) (130)
- Silicon (Other) (125) Other Substrates (122)

Equipment

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- Characterisation Post-processing
- Processing

Substrates

- Glass Wafers Silicon (CMOS Compatible) (137)
- Silicon (MEMS) (130)
- (125) Other Substrates (122)

Equipment

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Technologies

- Characterisation
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Substrates

- Glass Wafers Silicon (CMOS Compatible) (137)
- Silicon (MEMS) (130)
- (121)
- Other Substrates (122)

Equipment

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Silicon (Other)

Other Substrates

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Technologies

- Characterisation Post-processing
- Processing

Substrates

- Glass Wafers Silicon (CMOS Compatible) (137)
- Silicon (MEMS) (130) Silicon (Other) (121)
- (125) Other Substrates (122)

Equipment

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- Characterisation
- Post-processing
- Processing

Substrates

Glass Wafers Silicon (CMOS Compatible) (137) Silicon (MEMS) (130) Silicon (Other) (121) (125)

(122)

Other Substrates

Equipment

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- Characterisation
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Substrates

- Glass Wafers Silicon (CMOS Compatible) (137)
- Silicon (MEMS) (130)
- (125) Other Substrates (122)

Equipment

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Technologies

Electron-beam

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<u>Characterisation</u>

Post-processing

Processing

- Annealing
- Cleaning
- Dielectric Deposition
- Etching
- Lithography
- Electron-beam
- Optical Lithography.
- Metal Deposition Thin-film Deposition
- Wafer Bonding









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Substrates

Other Substrates

Glass Wafers (2) Silicon (CMOS Compatible) (3) Silicon (MEMS) (3) Silicon (Other) (2) III-V

(2)









Q

